

Notice of References Cited	Application/Control No. 10/619,581	Applicant(s)/Patent Under Reexamination RHEE ET AL.	
	Examiner Walter L. Lindsay, Jr.	Art Unit 2812	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-5,773,348	06-1998	Wu, Shye-Lin	438/305
	C	US-6,730,588	05-2004	Schinella, Richard	438/592
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	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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